

Autonomous system for web-based microarray image analysis

Bozinov, D.;
NanoBioscience, IEEE Transactions on
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 Digital Object Identifier: 10.1109/TNB.2003.817021
 Publication Year: 2003, Page(s): 215 - 220

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Standard for Information Technology - Portable Operating System Interface (POSIX) Shell and Utilities, Issue 6

IEEE Std 1003.1-2001, Shell and Utilities, Issue 6
Digital Object Identifier: 10.1109/IEEESTD.2001.93366
Publication Year: 2001, Page(s): i - 1090

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 Quick & Abstract

1003.1 Standard for Information Technology Portable Operating System Interface (POSIX) Rationale (Informative)

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A modular massively parallel computing approach to image-related processing

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**Implementation of an RBF neural network on embedded systems: real-time face tracking and identity verification**

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Paul, D.; Hattish, W.; Ndli, W.; Tamei, S.; Winkler, G.;

Pattern Analysis and Machine Intelligence, IEEE Transactions on

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